STW22N95K5



Automotive-grade N-channel 950 V, 0.280 Ω typ., 17.5 A MDmesh™ K5 Power MOSFET in a TO-247 package

Datasheet - production data

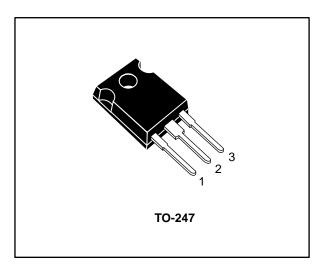
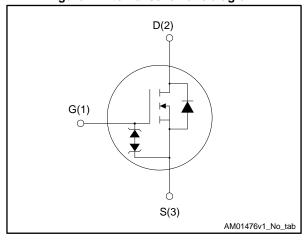
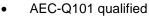


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	P _{TOT}
STW22N95K5	950 V	0.330 Ω	17.5 A	250 W





- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STW22N95K5	22N95K5	TO-247	Tube

Contents STW22N95K5

Contents

1	Electric	al ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	9
4	Packag	e information	10
	4.1	TO-247 package information	10
5	Revisio	n history	12

STW22N95K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	±30	V
I _D	Drain current (continuous) at T _C = 25 °C	17.5	Α
I _D	Drain current (continuous) at T _C = 100 °C	11	Α
I _D ⁽¹⁾	Drain current (pulsed)	70	Α
Ртот	Total dissipation at T _C = 25 °C	250	W
ESD	Gate-source human body model (R= 1.5 kΩ, C = 100 pF)	2	kV
dv/dt (2)	Peak diode recovery voltage slope	4.5	\
dv/dt (3)	MOSFET dv/dt ruggedness	50	V/ns
T _j	Operating junction temperature range	-55 to 150	°C
T _{stg}	Storage temperature range	-55 (0 150	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.5	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T _{jmax.})	6	Α
Eas	Single pulse avalanche energy (starting T_j = 25 °C, $I_D = I_{AR}, V_{DD}$ = 50 V)	182	mJ

 $[\]ensuremath{^{(1)}}\mbox{Pulse}$ width limited by safe operating area.

 $^{^{(2)}}I_{SD} \le 17.5 \text{ A, di/dt} \le 100 \text{ A/}\mu\text{s; } V_{DS} \text{ peak} \le V_{(BR)DSS}$

 $^{^{(3)}}V_{DS} \le 760 \text{ V}$

Electrical characteristics STW22N95K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	950			V
		V _{GS} = 0 V, V _{DS} = 950 V			1	μΑ
I _{DSS}	Zero-gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 950 \text{ V}$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μΑ
I _{GSS}	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}$		0.280	0.330	Ω

Notes:

Table 6: Dynamic

rabio o. Dynamio							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
Ciss	Input capacitance		ı	1550	ı	pF	
C_{oss}	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$	-	140	-	pF	
Crss	Reverse transfer capacitance	V G G — V V	-	1	-	pF	
C _{o(er)} ⁽¹⁾	Equivalent capacitance energy related	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ to}$	-	65	-	pF	
C _{o(tr)} ⁽²⁾	Equivalent capacitance time related	760 V		178	-	pF	
Rg	Intrinsic gate resistance	f = 1 MHz , I _D = 0 A	-	3.5	-	Ω	
Qg	Total gate charge	V _{DD} = 760 V,	-	48	-	nC	
Q_{gs}	Gate-source charge	I _D = 17.5 A	-	9	-	nC	
Q_gd	Gate-drain charge	V _{GS} = 10 V (see Figure 16: "Test circuit for gate charge behavior")	-	32.5	-	nC	

Notes:

4/13

 $[\]ensuremath{^{(1)}}\mbox{Defined}$ by design, not subject to production test.

 $^{^{(1)}}$ Co_(er) is a constant capacitance value that gives the same stored energy as Coss while VDs is rising from 0 to 80% VDss.

 $^{^{(2)}}$ Co(tr) is a constant capacitance value that gives the same charging time as Coss while Vps is rising from 0 to 80% Vpss.

Table 7: Switching times

Table 1. Ownering times								
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
t _{d(on)}	Turn-on delay time	V_{DD} = 475 V, I_{D} = 9 A, R_{G} = 4.7 Ω	-	18	-	ns		
tr	Rise time	V _{GS} = 10 V	-	9	-	ns		
t _{d(off)}	Turn-off delay time	(see Figure 15: "Test circuit for resistive load switching times" and Figure 20: "Switching time waveform")	-	65	-	ns		
t _f	Fall time	,	-	18	-	ns		

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		17.5	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		1		70	А
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 17.5 A, V _{GS} = 0 V	1		1.5	V
t _{rr}	Reverse recovery time	I _{SD} = 17.5 A, di/dt = 100 A/μs,	-	513		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V (see Figure 17: "Test circuit for	-	12		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")		46		Α
t _{rr}	Reverse recovery time	I _{SD} = 17.5 A, di/dt = 100 A/μs		670		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C (see Figure 17: "Test circuit for	-	15		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")		44		Α

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_{D} = 0 \text{ A}$	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

 $[\]ensuremath{^{(1)}}\mbox{Pulse}$ width limited by safe operating area.

 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%.

2.1 Electrical characteristics (curves)

Figure 2: Safe operating area

ID
(A)

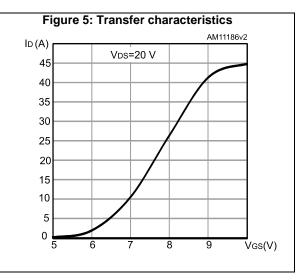
10 μs
100 μs
1 ms
10 ms

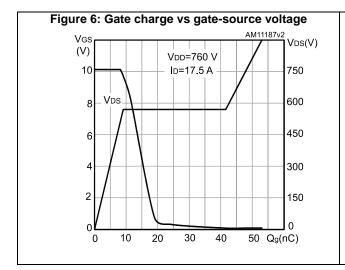
1 ms
10 ms
10 ms

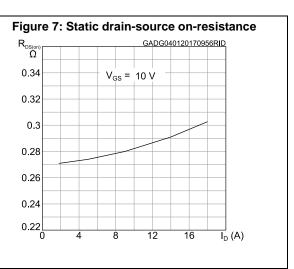
Figure 3: Thermal impedance GC18460

K $\delta = 0.5$ 0.2 0.02 0.01 0.02 0.02 0.02 0.02 0.02 0.02 0.03 0.03 0.03 0.03 0.03 0.03 0.03 0.03 0.

Figure 4: Output characteristics AM11185v2 Vgs=11 V 9 V 40 35 30 8 V 25 20 15 7 V 10 6 V 10 20 Vos(V)







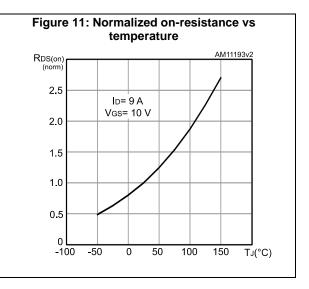
STW22N95K5 Electrical characteristics

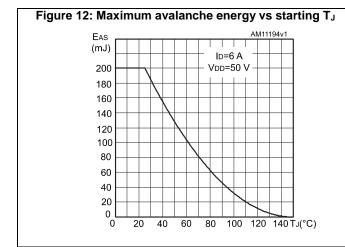
Figure 8: Capacitance variation

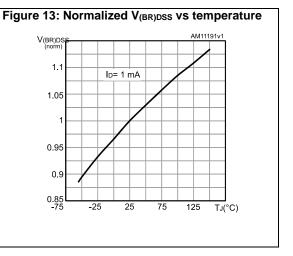
C
(pF)
10000
1000
Ciss
Coss
10
0.1
0.1
1 10 100 VDs(V)

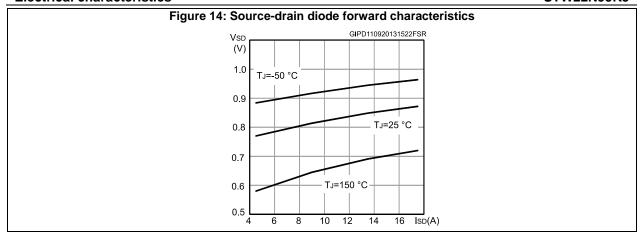
Figure 9: Output capacitance stored energy 24 22 20 18 16 14 12 10 8 6 4 2 200 400 600 800 V_{DS}(V)

Figure 10: Normalized gate threshold voltage vs temperature AM11192v2 VGS(th) (norm) 1.2 I_D= 100 μA 1.1 1.0 0.9 8.0 0.7 0.6 0.5 0.4 0.3 -50 150









STW22N95K5 Test circuits

3 Test circuits

Figure 15: Test circuit for resistive load switching times

Figure 16: Test circuit for gate charge behavior

VGS

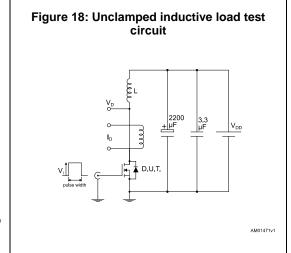
LG= CONST

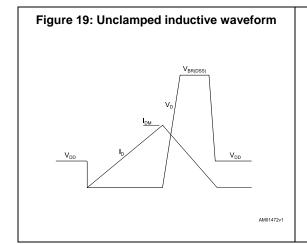
100 Ω

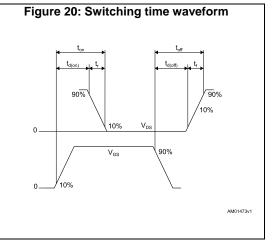
PL

AM01469v10

Figure 17: Test circuit for inductive load switching and diode recovery times







4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

Figure 21: TO-247 package outline HEAT-SINK PLANE øΡ S øR Ľ2 *b1 b2* BACK VIEW 0075325_8

Table 10: TO-247 package mechanical data

Dim	mm				
Dim.	Min.	Тур.	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
E	15.45		15.75		
е	5.30	5.45	5.60		
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
ØP	3.55		3.65		
ØR	4.50		5.50		
S	5.30	5.50	5.70		

Revision history STW22N95K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
17-Oct-2013	1	First release.
19-Dec-2013	2	Datasheet promoted from preliminary to production data Modified: title and <i>Features</i> Minor text changes
20-Mar-2014	3	 Modified: note 3 in Table 2 Modified: Q_{gs} and Q_{gd} typical values in <i>Table 5</i> Modified: typical values in <i>Table 6</i> and 7 Updated: <i>Figure 6</i> Minor text changes
11-Jan-2017	4	Updated title, features and description in cover page. Minor text changes in Section 1: "Electrical ratings" and Section 2: "Electrical characteristics". Changed Figure 7: "Static drain-source on-resistance".

IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2017 STMicroelectronics - All rights reserved



X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by STMicroelectronics manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B DMN1006UCA6-7